

Dual Enhancement Mode MOSFET (N-and P-Channel)

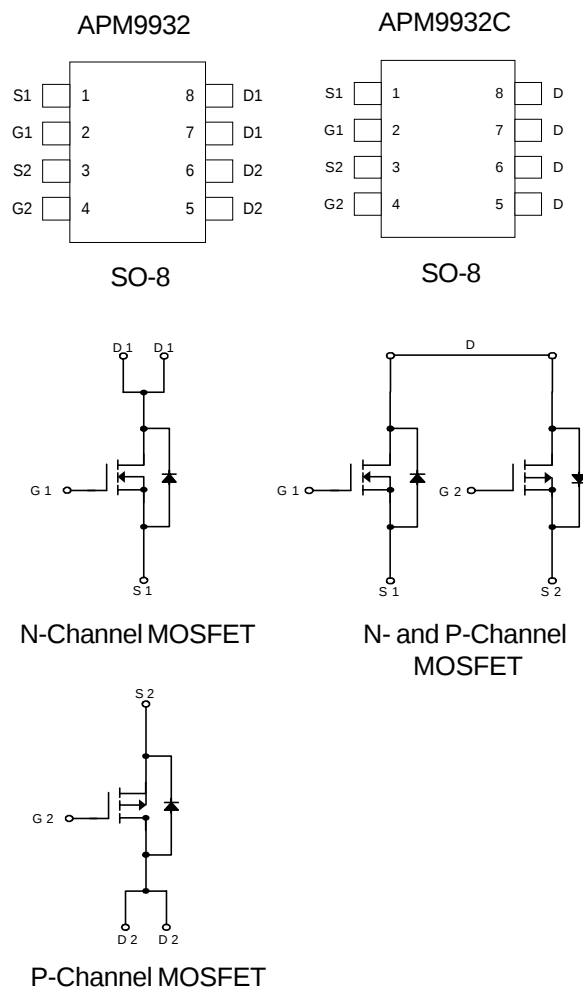
Features

- N-Channel
20V/15A, $R_{DS(ON)} = 12m\Omega (typ.) @ V_{GS} = 10V$
 $R_{DS(ON)} = 17m\Omega (typ.) @ V_{GS} = 4.5V$
- P-Channel
-20V/-6A, $R_{DS(ON)} = 30m\Omega (typ.) @ V_{GS} = -4.5V$
 $R_{DS(ON)} = 45m\Omega (typ.) @ V_{GS} = -2.5V$
- Super High Dense Cell Design for Extremely Low $R_{DS(ON)}$
- Reliable and Rugged
- SO-8 Package

Applications

- Power Management in Notebook Computer ,
Portable Equipment and Battery Powered
Systems.

Pin Description



Ordering and Marking Information

APM9932/C XX-XX Handling Code Temp. Range Package Code	Package Code K : SO-8 Operation Junction Temp. Range C : -55 to 150°C Handling Code TR : Tape & Reel
APM9932/C K : APM9932/C XXXXX	XXXXX - Date Code

ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter		N-Channel	P-Channel	Unit
V _{DSS}	Drain-Source Voltage		20	-20	V
V _{GSS}	Gate-Source Voltage		±16	±12	
I _D [*]	Maximum Drain Current – Continuous		15	-6	A
I _{DM}	Maximum Drain Current – Pulsed		30	-10	
P _D	Maximum Power Dissipation	T _A =25°C	2.5	2.5	W
		T _A =100°C	1.0	1.0	
T _J	Maximum Junction Temperature		150		°C
T _{STG}	Storage Temperature Range		-55 to 150		°C
R _{θJA}	Thermal Resistance – Junction to Ambient		50		°C/W

* Surface Mounted on FR4 Board, $t \leq 10$ sec.

Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Condition	APM9932/C			Unit	
			Min.	Typ.	Max.		
Static							
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _{DS} =250μA	N-Ch	20		V	
			P-Ch	-20			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =18V , V _{GS} =0V	N-Ch		1	μA	
		V _{DS} =-18V , V _{GS} =0V	P-Ch		-1		
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	N-Ch	0.6	1.3	V	
		V _{DS} =V _{GS} , I _{DS} =-250μA	P-Ch	-0.6	-1.3		
I _{GSS}	Gate Leakage Current	V _{GS} =±16V , V _{DS} =0V	N-Ch		±100	nA	
		V _{GS} =±12V , V _{DS} =0V	P-Ch		±100		
R _{DS(ON)} ^a	Drain-Source On-state Resistance	V _{GS} =10V , I _{DS} =9A	N-Ch		12	18	mΩ
		V _{GS} =4.5V , I _{DS} =7A			17	27	
		V _{GS} =-4.5V , I _{DS} =-6A	P-Ch		30	42	
		V _{GS} =-2.5V , I _{DS} =-5A			45	60	
V _{SD} ^a	Diode Forward Voltage	I _{SD} =5A , V _{GS} =0V	N-Ch	0.6		1.3	V
		I _{SD} =-2A , V _{GS} =0V	P-Ch	-0.6		-1.3	

Notes

^a : Pulse test ; pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$

Electrical Characteristics (Cont.) ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Condition	APM9932/C			Unit	
			Min.	Typ.	Max.		
Dynamic ^a							
Q _g	Total Gate Charge	N-Channel V _{DS} =10V , I _{DS} = 6A	N-Ch		14	22	nC
			P-Ch		19	25	
Q _{gs}	Gate-Source Charge	V _{GS} =4.5V P-Channel	N-Ch		5		
			P-Ch		4.1		
Q _{gd}	Gate-Drain Charge	V _{DS} =-4V , I _{DS} =-1A V _{GS} =-4.5V	N-Ch		2.8		
			P-Ch		1.6		
t _{d(ON)}	Turn-on Delay Time	N-Channel V _{DD} =10V , I _{DS} =1A , V _{GEN} =4.5V , R _G =10Ω	N-Ch		6	12	ns
			P-Ch		23	45	
T _r	Turn-on Rise Time	P-Channel V _{DD} =-4V , I _{DS} =-1A , V _{GEN} =-4.5V , R _G =10Ω	N-Ch		5	10	
			P-Ch		45	80	
t _{d(OFF)}	Turn-off Delay Time		N-Ch		16	40	
			P-Ch		45	90	
T _f	Turn-off Fall Time		N-Ch		5	20	
			P-Ch		32	55	
C _{iss}	Input Capacitance	N-Channel V _{GS} =0V , V _{DS} =15V	N-Ch		1225		pF
			P-Ch		1400		
C _{oss}	Output Capacitance	Frequency=1.0MHz P-Channel	N-Ch		330		
			P-Ch		520		
C _{rss}	Reverse Transfer Capacitance	V _{GS} =0V , V _{DS} =-4V Frequency=1.0MHz	N-Ch		220		
			P-Ch		320		

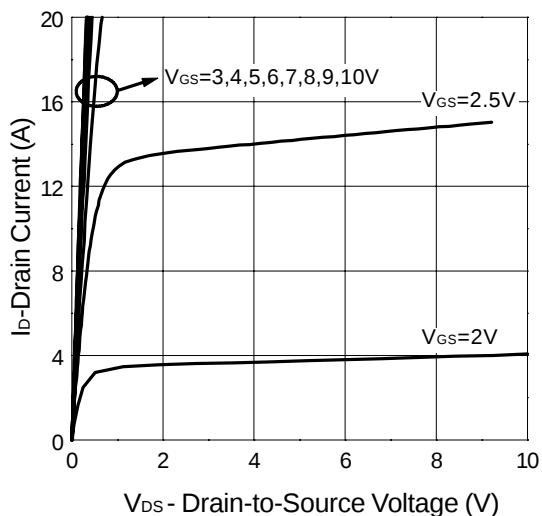
Notes

^a : Guaranteed by design, not subject to production testing

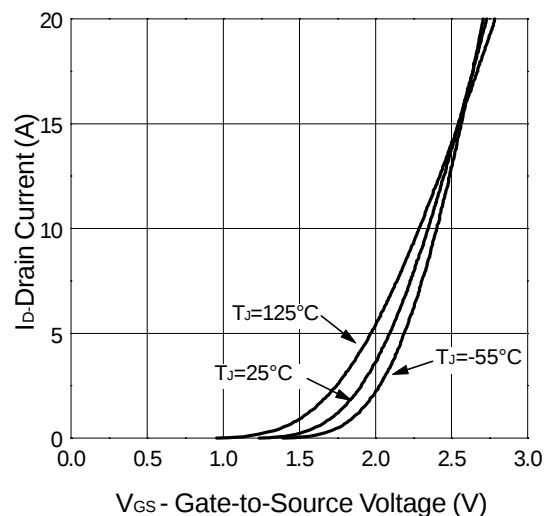
Typical Characteristics

N-Channel

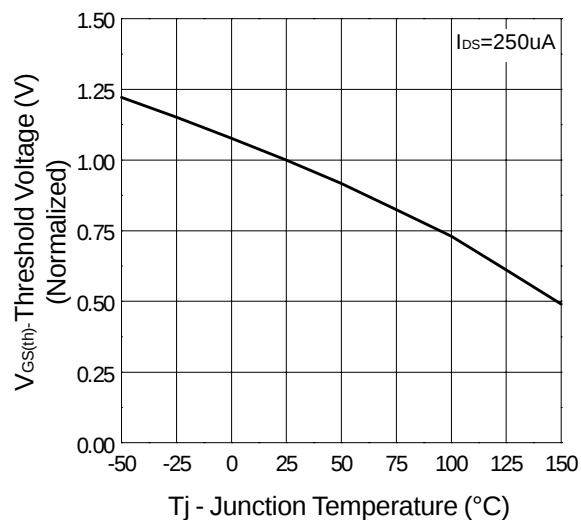
Output Characteristics



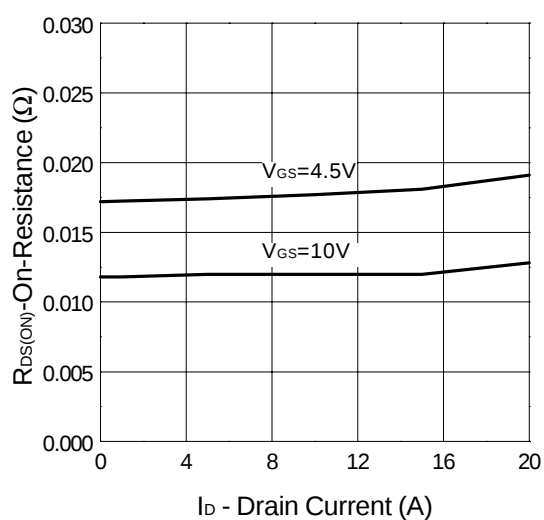
Transfer Characteristics



Threshold Voltage vs. Junction Temperature



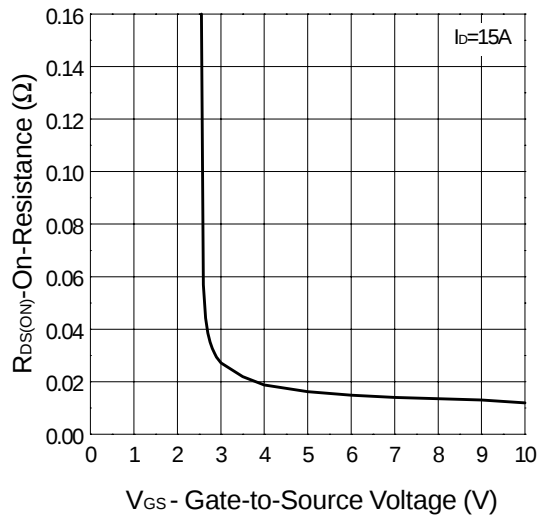
On-Resistance vs. Drain Current



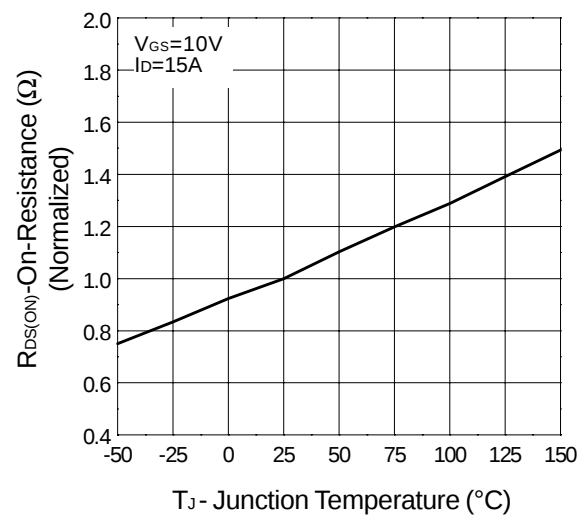
Typical Characteristics (Cont.)

N-Channel

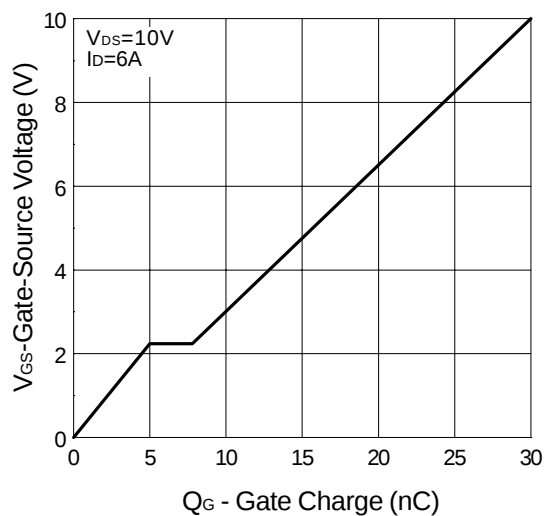
On-Resistance vs. Gate-to-Source Voltage



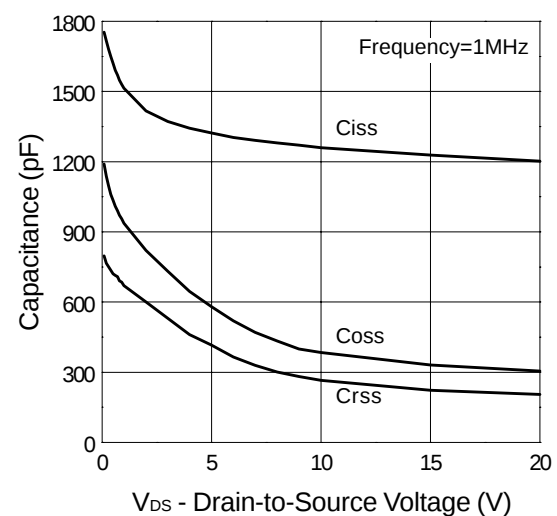
On-Resistance vs. Junction Temperature



Gate Charge

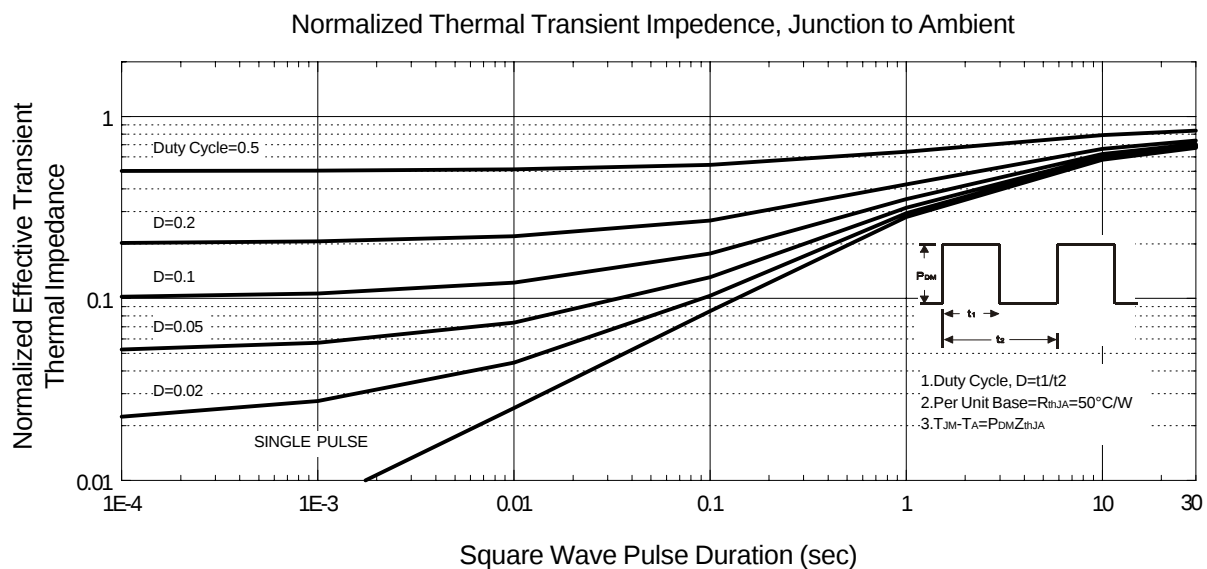
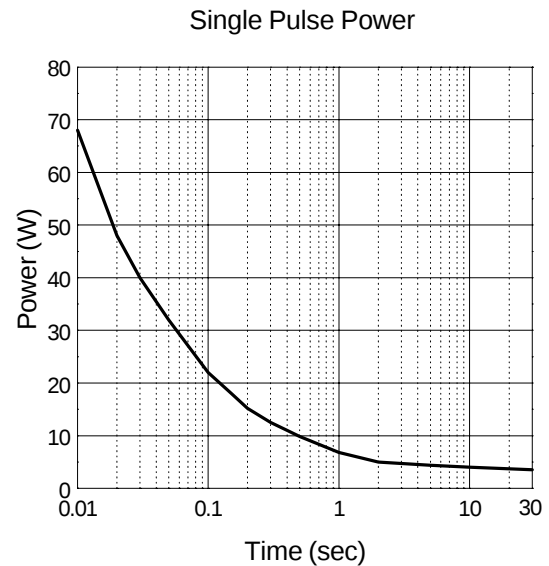
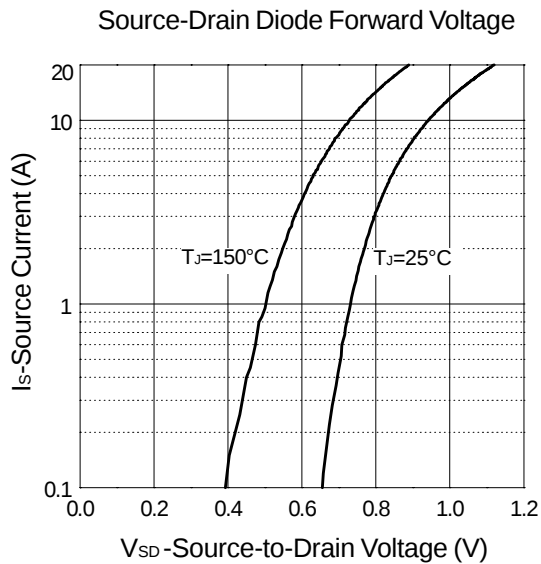


Capacitance



Typical Characteristics (Cont.)

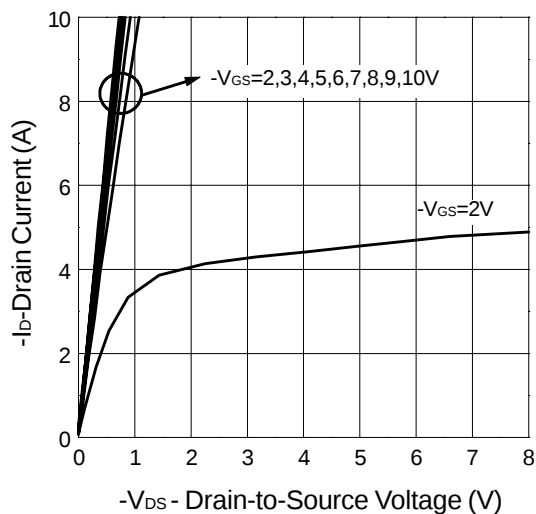
N-Channel



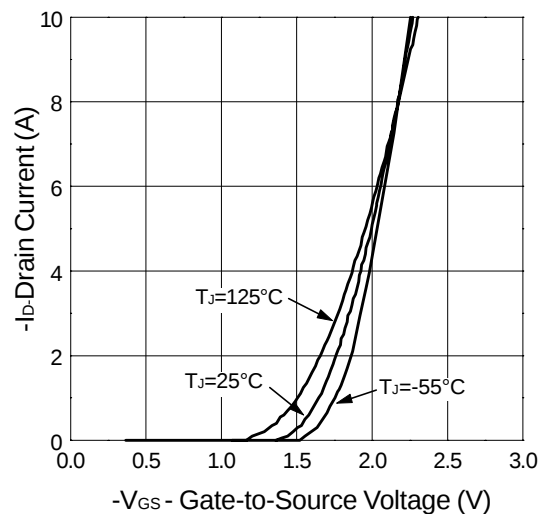
Typical Characteristics

P-Channel

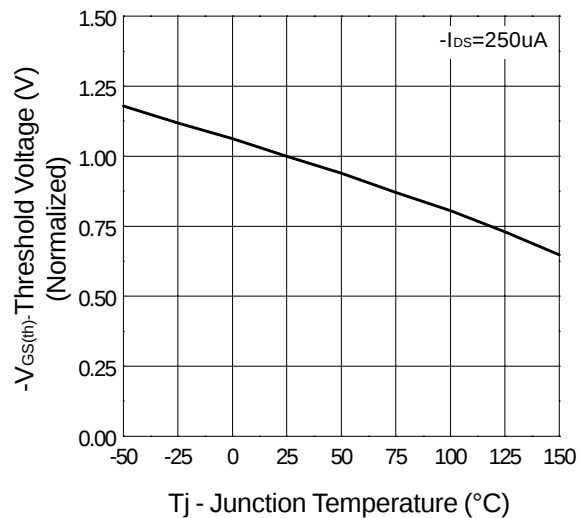
Output Characteristics



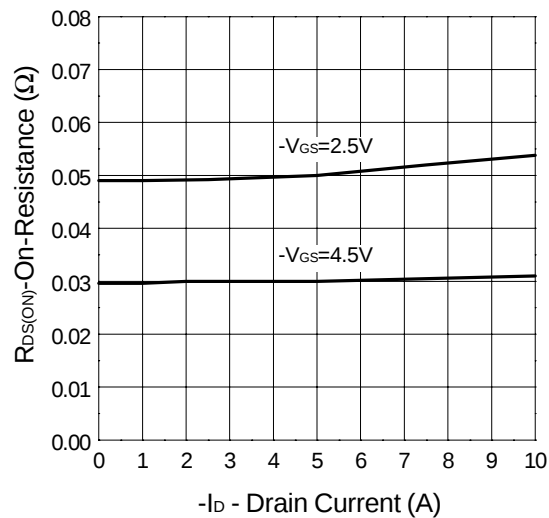
Transfer Characteristics



Threshold Voltage vs. Junction Temperature

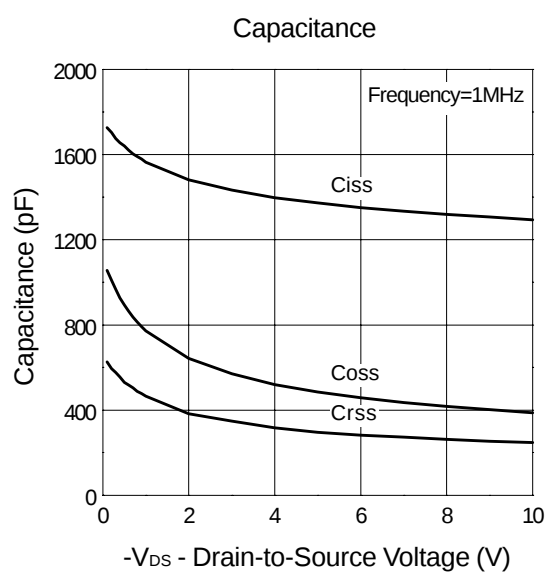
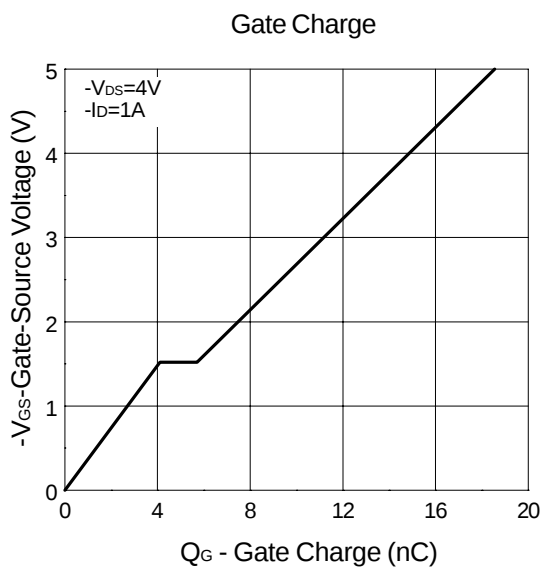
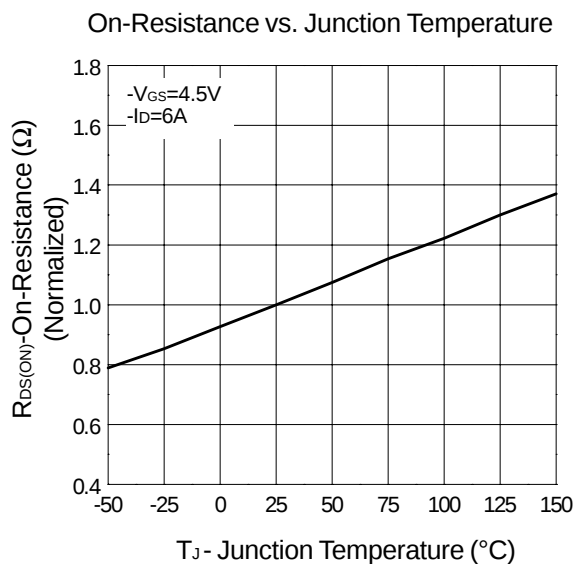
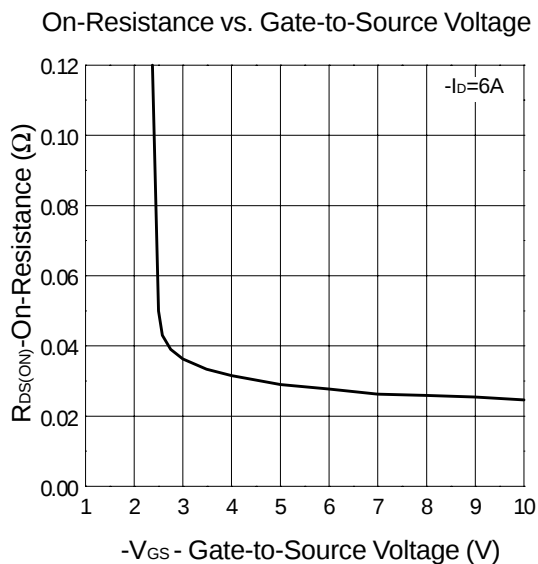


On-Resistance vs. Drain Current



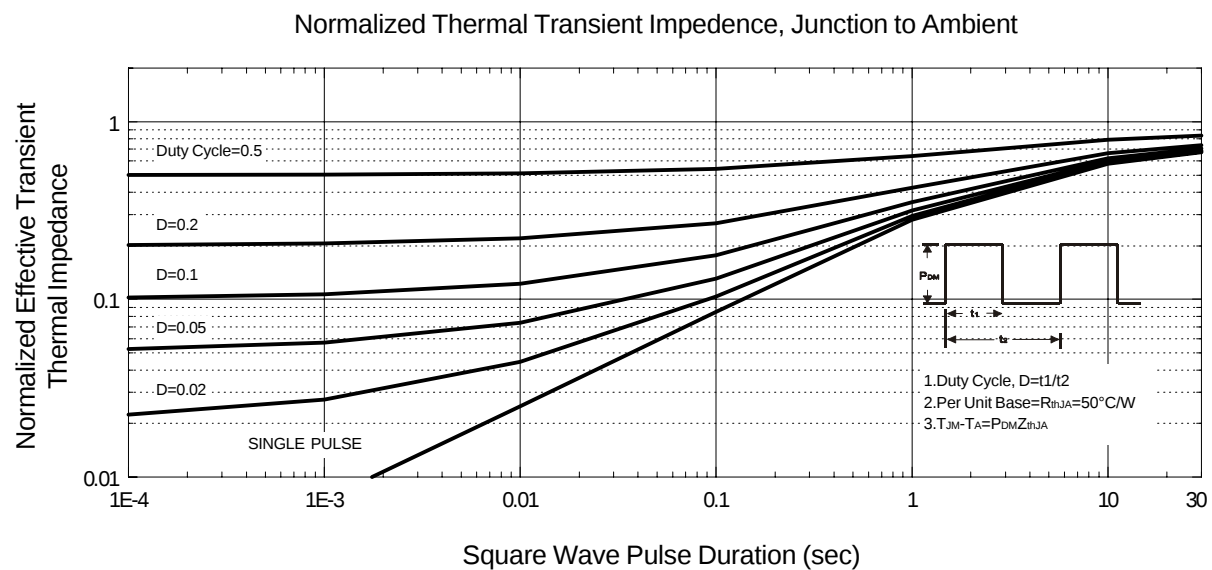
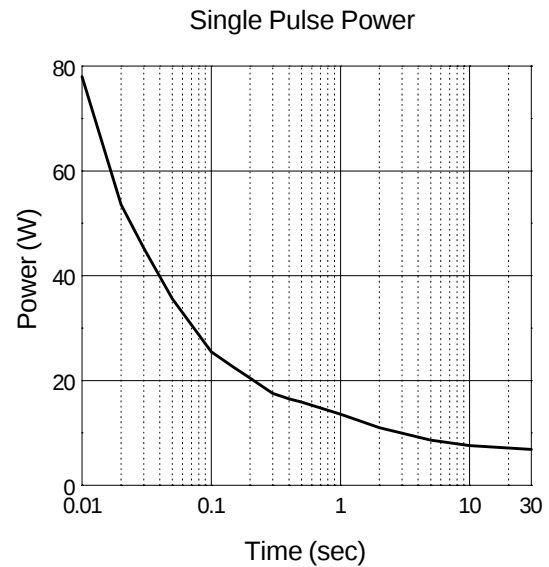
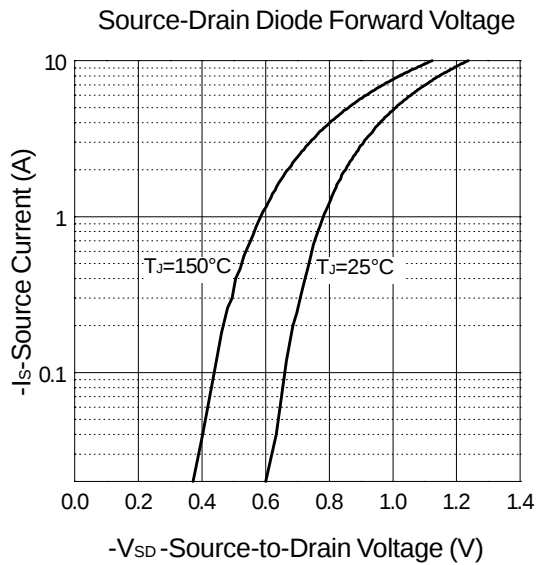
Typical Characteristics (Cont.)

P-Channel



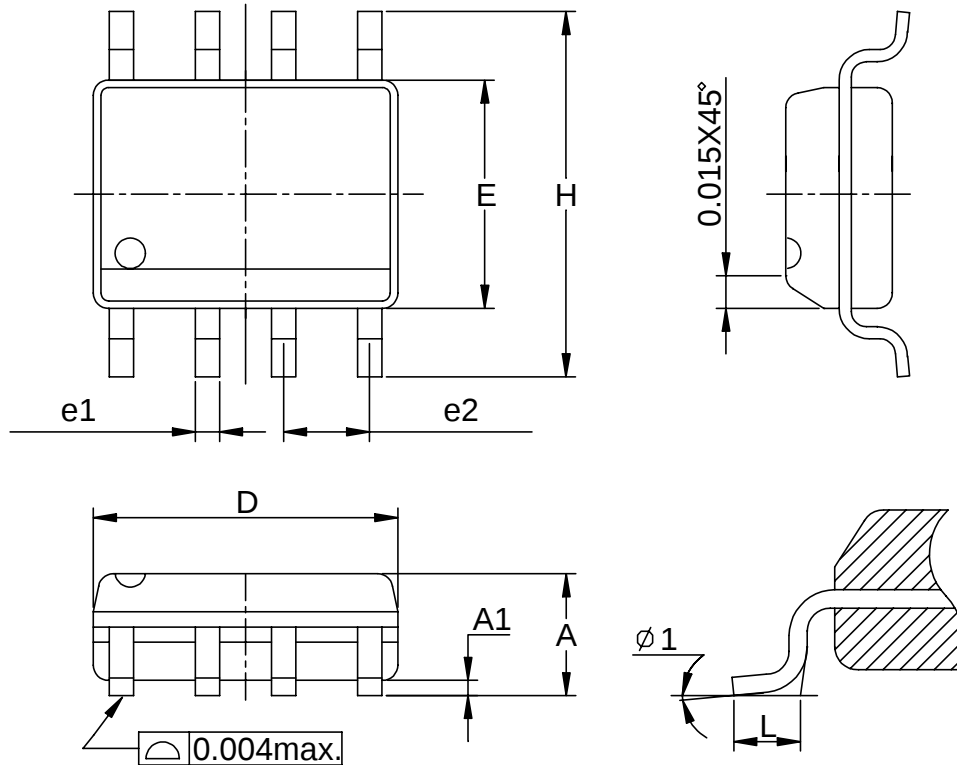
Typical Characteristics (Cont.)

P-Channel



Packaging Information

SOP-8 pin (Reference JEDEC Registration MS-012)



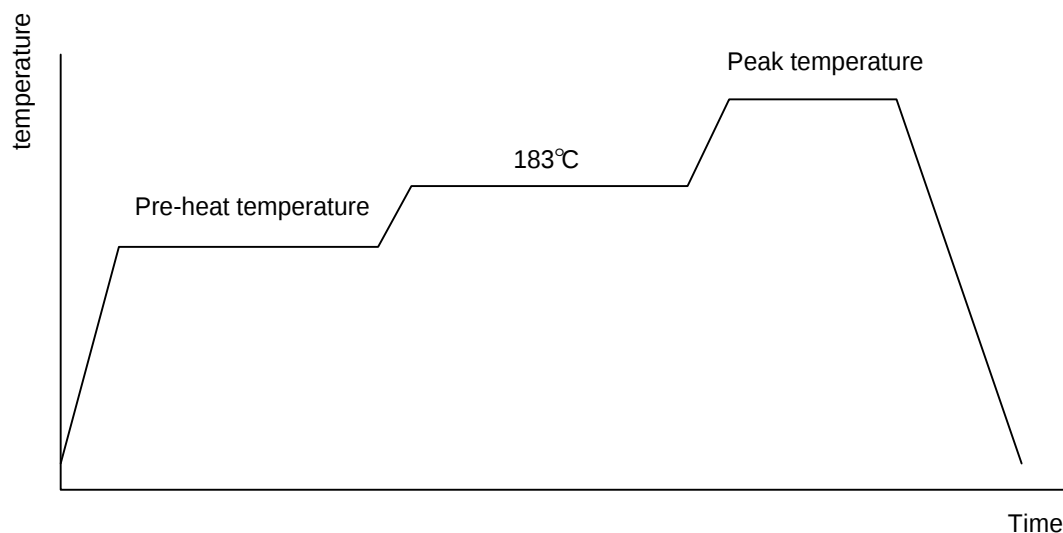
Dim	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	1.35	1.75	0.053	0.069
A1	0.10	0.25	0.004	0.010
D	4.80	5.00	0.189	0.197
E	3.80	4.00	0.150	0.157
H	5.80	6.20	0.228	0.244
L	0.40	1.27	0.016	0.050
e1	0.33	0.51	0.013	0.020
e2	1.27BSC		0.50BSC	
$\phi 1$	8°		8°	

Physical Specifications

Terminal Material	Solder-Plated Copper (Solder Material : 90/10 or 63/37 SnPb)
Lead Solderability	Meets EIA Specification RSI86-91, ANSI/J-STD-002 Category 3.

Reflow Condition (IR/Convection or VPR Reflow)

Reference JEDEC Standard J-STD-020A APRIL 1999



Classification Reflow Profiles

	Convection or IR/ Convection	VPR
Average ramp-up rate(183°C to Peak)	3°C/second max.	10 °C /second max.
Preheat temperature 125 ± 25°C)	120 seconds max	
Temperature maintained above 183°C	60 – 150 seconds	
Time within 5°C of actual peak temperature	10 – 20 seconds	60 seconds
Peak temperature range	220 +5/-0°C or 235 +5/-0°C	215-219°C or 235 +5/-0°C
Ramp-down rate	6 °C /second max.	10 °C /second max.
Time 25°C to peak temperature	6 minutes max.	

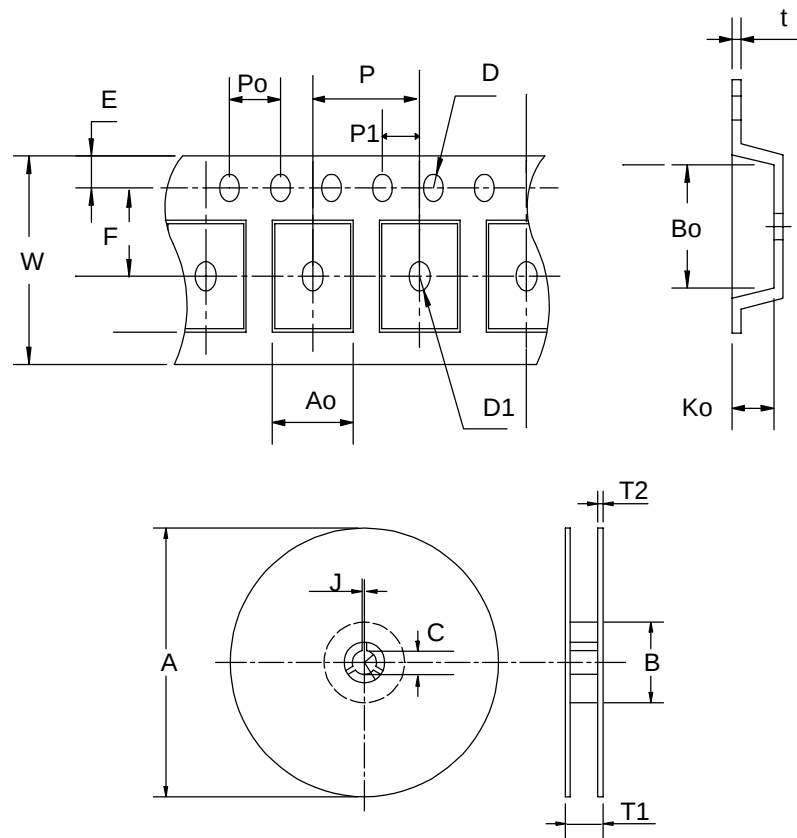
Package Reflow Conditions

pkg. thickness ≥ 2.5mm and all bgas	pkg. thickness < 2.5mm and pkg. volume ≥ 350 mm ³	pkg. thickness < 2.5mm and pkg. volume < 350mm ³
Convection 220 +5/-0 °C		Convection 235 +5/-0 °C
VPR 215-219 °C		VPR 235 +5/-0 °C
IR/Convection 220 +5/-0 °C		IR/Convection 235 +5/-0 °C

Reliability test program

Test item	Method	Description
SOLDERABILITY	MIL-STD-883D-2003	245°C, 5 SEC
HOLT	MIL-STD 883D-1005.7	1000 Hrs Bias @ 125°C
PCT	JESD-22-B, A102	168 Hrs, 100% RH, 121°C
TST	MIL-STD 883D-1011.9	-65°C ~ 150°C, 200 Cycles

Carrier Tape & Reel Dimensions



Application	A	B	C	J	T1	T2	W	P	E
SOP- 8	330 ± 1	62 +1.5	12.75+ 0.15	2 ± 0.5	12.4 ± 0.2	2 ± 0.2	12± 0.3	8± 0.1	1.75±0.1
	F	D	D1	P0	P1	A0	Bo	Ko	t
	5.5± 1	1.55 +0.1	1.55+ 0.25	4.0 ± 0.1	2.0 ± 0.1	6.4 ± 0.1	5.2± 0.1	2.1± 0.1	0.3±0.013

Cover Tape Dimensions

Application	Carrier Width	Cover Tape Width	Devices Per Reel
SOP- 8	12	9.3	2500

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